


<b>Search Notes</b>  	<b>Application/Control No.</b>  10733319	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  Hasan, Syed Y	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	124	12/19/2007	Syed Y. Hasan
386	96	12/19/2007	Syed Y. Hasan
386	101	12/19/2007	Syed Y. Hasan
386	112	12/19/2007	Syed Y. Hasan
348	518	12/19/2007	Syed Y. Hasan
375	240.28	12/19/2007	Syed Y. Hasan
375	E7.01	12/19/2007	Syed Y. Hasan
375	E7.273	12/19/2007	Syed Y. Hasan

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/19/2007	Syed Y. Hasan
Consultation with Thai Tran	12/18/2007	Syed Y. Hasan

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner